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10/812,277 Examiner

Monica Lewis

Applicant(s)/Patent under Reexamination

CHAO ET AL.

Art Unit

2822

SEARCHED			
Class	Subclass	Date	Examiner
257	734,737, 738, 777-781	6/17/2006	ML
257	E.23.065	6/17/2006	ML
	-		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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Interferen	ce Search	6/17/2006	ML

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EIC Search	6/17/2006	ML
East Search	6/17/2006	ML
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